



2–16 GHz Low Noise Gallium Arsenide FET

Technical Data

ATF-13336

Features

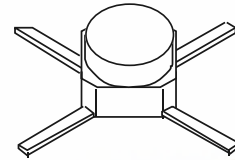
- **Low Noise Figure:**
1.4 dB Typical at 12 GHz
- **High Associated Gain:**
9.0 dB Typical at 12 GHz
- **High Output Power:**
17.5 dBm Typical $P_{1\text{ dB}}$ at 12 GHz
- **Cost Effective Ceramic Microstrip Package**
- **Tape-and-Reel Packaging Option Available^[1]**

Description

The ATF-13336 is a high performance gallium arsenide Schottky-barrier-gate field effect transistor housed in a cost effective microstrip package. Its premium noise figure makes this device appropriate for use in low noise amplifiers operating in the 2-16 GHz frequency range.

This GaAs FET device has a nominal 0.3 micron gate length with a total gate periphery of 250 microns. Proven gold based metallization systems and nitride passivation assure a rugged, reliable device.

36 micro-X Package



Electrical Specifications, $T_A = 25^\circ\text{C}$

Symbol	Parameters and Test Conditions	Units	Min.	Typ.	Max.
NF ₀	Optimum Noise Figure: $V_{DS} = 2.5\text{ V}$, $I_{DS} = 20\text{ mA}$	f = 8.0 GHz dB f = 12.0 GHz dB f = 14.0 GHz dB		1.2 1.4 1.6	1.6
G _A	Gain @ NF ₀ : $V_{DS} = 2.5\text{ V}$, $I_{DS} = 20\text{ mA}$	f = 8.0 GHz dB f = 12.0 GHz dB f = 14.0 GHz dB	8.0	11.5 9.0 7.5	
P _{1 dB}	Power Output @ 1 dB Gain Compression: $V_{DS} = 4\text{ V}$, $I_{DS} = 40\text{ mA}$	f = 12.0 GHz		17.5	
G _{1 dB}	1 dB Compressed Gain: $V_{DS} = 4\text{ V}$, $I_{DS} = 40\text{ mA}$	f = 12.0 GHz		8.5	
g _m	Transconductance: $V_{DS} = 2.5\text{ V}$, $V_{GS} = 0\text{ V}$		25	55	
I _{DSS}	Saturated Drain Current: $V_{DS} = 2.5\text{ V}$, $V_{GS} = 0\text{ V}$		40	50	90
V _p	Pinch-off Voltage: $V_{DS} = 2.5\text{ V}$, $I_{DS} = 1\text{ mA}$		-4.0	-1.5	-0.5

Note:
1. Refer to PACKAGING section "Tape-and-Reel Packaging for Surface Mount Semiconductors".



ATF-13336 Absolute Maximum Ratings

Symbol	Parameter	Units	Absolute Maximum ^[1]
V _{DS}	Drain-Source Voltage	V	+5
V _{GS}	Gate-Source Voltage	V	-4
V _{GD}	Gate-Drain Voltage	V	-6
I _{DS}	Drain Current	mA	I _{DSS}
P _T	Power Dissipation ^[2,3]	mW	225
T _{CH}	Channel Temperature	°C	175
T _{STG}	Storage Temperature	°C	-65 to +175

Thermal Resistance: $\theta_{jc} = 400^{\circ}\text{C}/\text{W}; T_{CH} = 150^{\circ}\text{C}$
Liquid Crystal Measurement: 1 μm Spot Size^[5]

Part Number Ordering Information

Part Number	Devices Per Reel	Reel Size
ATF-13336-TR1	1000	7"
ATF-13336-STR	10	strip

ATF-13336 Noise Parameters: V_{DS} = 2.5 V, I_{DS} = 20 mA

Freq. GHz	NF _O dB	Γ_{opt}		R _N /50
		Mag	Ang	
4.0	0.8	.63	93	.27
6.0	1.1	.47	138	.10
8.0	1.2	.40	-153	.20
12.0	1.4	.52	-45	.88
14.0	1.6	.57	-2	1.3

ATF-13336 Typical Performance, T_A = 25°C

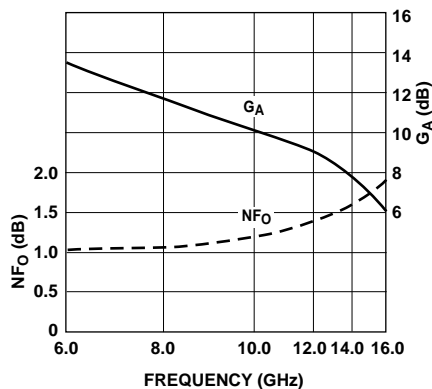


Figure 1. Optimum Noise Figure and Associated Gain vs. Frequency.
V_{DS} = 2.5V, I_{DS} = 20 mA, T_A = 25°C.

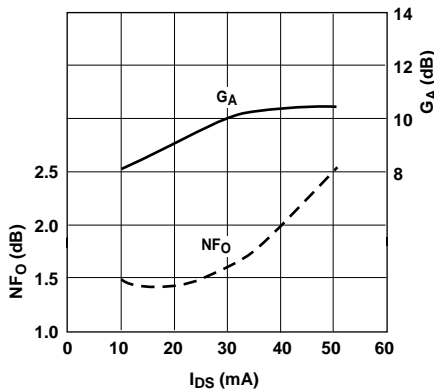


Figure 2. Optimum Noise Figure and Associated Gain vs. I_{DS}.
V_{DS} = 2.5V, f = 12.0 GHz.

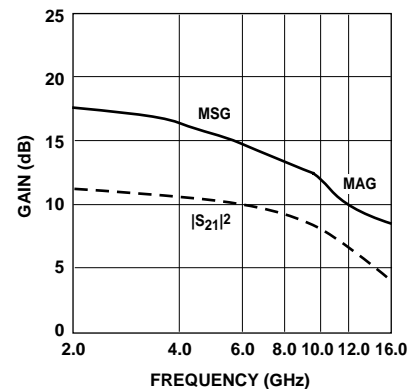


Figure 3. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency.
V_{DS} = 2.5 V, I_{DS} = 20 mA.

Notes:

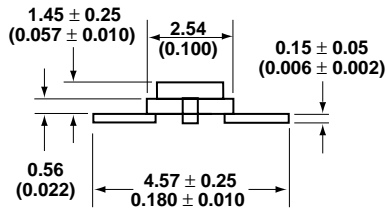
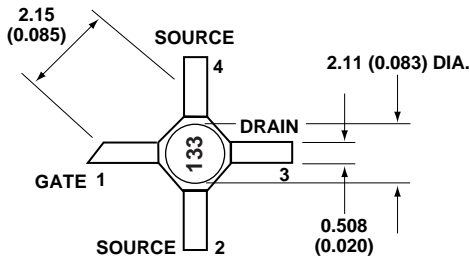
1. Permanent damage may occur if any of these limits are exceeded.
2. T_{CASE} TEMPERATURE = 25°C.
3. Derate at 2.5mW/°C for T_{CASE} > 85°C.
4. Storage above +150°C may tarnish the leads of this package difficult to solder into a circuit. After a device has been soldered into a circuit, it may be safely stored up to 175°C.
4. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section for more information.

Typical Scattering Parameters, Common Emitter, $Z_O = 50 \Omega$, $T_A = 25^\circ\text{C}$, $V_{DS} = 2.5\text{V}$, $I_{DS} = 20\text{mA}$

Freq. GHz	S_{11}		dB	S_{21}		dB	S_{12}		S_{22}	
	Mag.	Ang.		Mag.	Ang.		Mag.	Ang.	Mag.	Ang.
2.0	.96	-51	10.6	3.39	127	-27.1	.044	57	.61	-41
3.0	.88	-75	10.3	3.28	106	-23.4	.060	33	.58	-51
4.0	.86	-96	10.1	3.19	86	-22.6	.074	25	.57	-57
5.0	.79	-117	9.9	3.13	66	-20.6	.093	12	.54	-65
6.0	.69	-142	10.2	3.22	46	-18.9	.114	1	.49	-79
7.0	.60	-178	10.1	3.21	21	-17.6	.132	-18	.42	-97
8.0	.54	141	9.8	3.10	-4	-17.3	.137	-33	.31	-112
9.0	.56	103	8.9	2.80	-26	-16.7	.147	-48	.21	-121
10.0	.56	74	8.3	2.60	-48	-16.5	.150	-63	.09	-145
11.0	.58	44	7.6	2.39	-68	-16.8	.145	-78	.07	89
12.0	.63	20	6.7	2.17	-90	-17.5	.133	-95	.16	43
13.0	.65	3	6.0	2.00	-108	-18.3	.121	-107	.19	21
14.0	.66	-7	5.5	1.89	-126	-18.9	.114	-121	.19	-4
15.0	.70	-19	4.9	1.76	-144	-19.0	.112	-129	.16	-28
16.0	.72	-34	4.4	1.66	-175	-19.2	.110	-142	.14	-32

A model for this device is available in the DEVICE MODELS section.

36 micro-X Package Dimensions



Notes:

1. Dimensions are in millimeters (inches)
2. Tolerances: in .xxx = ± 0.005
mm .xx = ± 0.13